10026560_CLSTITLES

Titles of Most Frequently Occurring Classifications of Patents Returne

From A Search of 10026560 on August 10, 2004

16	Class	365 .01	OR, 9 XR) : STATIC INFORMATION STORAGE AND RETRIEVAL READ/WRITE CIRCUIT .Testing
9	714/718 Class 714/699 714/718	714	
7	714/719 Class 714/699 714/718 714/719	714	OR, 5 XR) : ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING .Memory testingRead-in with read-out and compare
5	714/733 Class 714/699 714/724 714/733	714	OR, 5 XR) : ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING .Digital logic testingBuilt-in testing circuit (BILBO)
4	714/736 Class 714/699 714/724 714/736	714	
3	714/721 Class 714/699 714/718 714/721	714	OR, 2 XR) : ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING .Memory testingElectrical parameter (e.g., threshold voltage)
3	714/722 Class	(1 714	OR, 2 XR) : ERROR DETECTION/CORRECTION AND FAULT

10026560 CLSTITLES DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING 714/699 714/718 .Memory testing .. Performing arithmetic function on memory 714/722 contents (2 OR, 1 XR) 714/724 714 : ERROR DETECTION/CORRECTION AND FAULT Class DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING 714/699 714/724 .Digital logic testing (1 OR, 2 XR) 714/732 714 : ERROR DETECTION/CORRECTION AND FAULT DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING 714/699 714/724 .Digital logic testing 714/732 ...Signature analysis 714/743 (0 OR, 3 XR)714 : ERROR DETECTION/CORRECTION AND FAULT Class DETECTION/RECOVERY 714/699 PULSE OR DATA ERROR HANDLING .Digital logic testing 714/724 .. Including test pattern generator 714/738 714/743 ... Addressing (0 OR, 2 XR) 2 123/480 Class 123 : INTERNAL-COMBUSTION ENGINES CHARGE FORMING DEVICE (E.G., POLLUTION CONTROL 123/434 .Fuel injection system 123/445 .. Electrically actuated injector 123/472 ... Actuator circuit (e.g., engine condition 123/478 responsive electronic circuit actuates inj ector valve) 123/480 Having microprocessor 365/104 (1 OR, 1 XR) 365 : STATIC INFORMATION STORAGE AND RETRIEVAL Class READ ONLY SYSTEMS (I.E.. SEMIPERMANENT) 365/94 .Semiconductive 365/103 ..Transistors 365/104 2 365/189.07 (0 OR, 2 XR) 365 : STATIC INFORMATION STORAGE AND RETRIEVAL

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Class

365/189.01

READ/WRITE CIRCUIT

10026560 CLSTITLES .Including signal comparison 365/189.07 (1 OR, 1 XR) 365/230.03 365 : STATIC INFORMATION STORAGE AND RETRIEVAL Class ADDRESSING 365/230.01 .Plural blocks or banks 365/230.03 (1 OR, 1 XR)365/230.06 365 : STATIC INFORMATION STORAGE AND RETRIEVAL ADDRESSING 365/230.01 .Particular decoder or driver circuit 365/230.06 (2 OR, 0 XR) 701/102 701 : DATA PROCESSING: VEHICLES, NAVIGATION, AND Class RELATIVE LOCATION VEHICLE CONTROL, GUIDANCE, OPERATION, OR 701/1 INDICATION .With indicator or control of power plant 701/99 (e.g., performance) .. Internal-combustion engine 701/101 ...Digital or programmed data processor 701/102 712/245 (1 OR, 1 XR) 712 : ELECTRICAL COMPUTERS AND DIGITAL PROCESSING Class SYSTEMS: PROCESSING ARCHITECTURES AND TRUCTION PROCESSING PROCESSING CONTROL 712/220 .Processing sequence control (i.e., 712/245 microsequencing) 2 714/32 (1 OR, 1 XR)714 : ERROR DETECTION/CORRECTION AND FAULT Class DETECTION/RECOVERY DATA PROCESSING SYSTEM ERROR OR FAULT HANDLING 714/100 .Reliability and availability 714/1 .. Fault locating (i.e., diagnosis or testing) 714/25 ...Particular stimulus creation 714/32 2 714/720 (1 OR, 1 XR)714 : ERROR DETECTION/CORRECTION AND FAULT Class DETECTION/RECOVERY PULSE OR DATA ERROR HANDLING 714/699 .Memory testing 714/718 ..Read-in with read-out and compare 714/719

714/720

... Special test pattern (e.g., checkerboard,

10026560_CLSTITLES walking ones)

	2	714/727	(1	OR, 1 XR)
		Class	714	: ERROR DETECTION/CORRECTION AND FAULT
				DETECTION/RECOVERY
		714/699		
		714/724		.Digital logic testing
		714/726		Scan path testing (e.g., level sensitive sca
n				design (LSSD))
		714/727		Boundary scan
		114/121		boundary beam
	2	714/734	(0	OR, 2 XR)
		Class	714	: ERROR DETECTION/CORRECTION AND FAULT
				DETECTION/RECOVERY
		714/699		
		714/724		
		714/734		Structural (in-circuit test)
	2	714/735	(0	OR 2 YR)
	2	/14//33 Class	71/	: ERROR DETECTION/CORRECTION AND FAULT
		Class	114	DETECTION/RECOVERY
		714/699		-
		714/033		.Digital logic testing
		714/724		Device response compared to input pattern
		/14//33		Device response compared to imput passes
	2	714/738	(0	OR, 2 XR)
		Class	714	: ERROR DETECTION/CORRECTION AND FAULT
				DETECTION/RECOVERY
		714/699		PULSE OR DATA ERROR HANDLING
		714/724		.Digital logic testing
		714/738		Including test pattern generator

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Most Frequently Occurring Classifications of Patents Returned From A Search of 10026560 on August 10, 2004

Original Classifications 365/201 714/718 3 714/736 2 701/102 714/719 2 714/724 Cross-Reference Classifications 9 365/201 6 714/718 5 714/719 5 714/733 3 714/743 2 123/480 2 365/189.07 2 714/721 714/722 2 714/732 2 714/734 2 714/735 714/738 Combined Classifications 16 365/201 714/718 7 714/719 5 714/733 4 714/736 3 714/721 3 714/722 3 714/724 3 714/732 714/743 2 123/480 2 365/104 2 365/189.07 2 365/230.03 2 365/230.06 2 701/102 2 712/245 2 714/32 714/720

2 714/727

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- 714/734 714/735 714/738

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Original Classifications 7 365/201 3 714/718 3 714/736 2 701/102 714/719 2 2 714/724 Cross-Reference Classifications 365/201 714/718 6 5 714/719 5 714/733 714/743 3 2 123/480 2 365/189.07 2 714/721 2 714/722 2 714/732 2 714/734 714/735 2 714/738 Combined Classifications 16 365/201 9 714/718 714/719 5 714/733 714/736 4 714/721 3 3 714/722 3 714/724 3 714/732 3 714/743 2 123/480 2 365/104 2 365/189.07 2 365/230.03 2 365/230.06 2 701/102 2 712/245 2 714/32 2 714/720

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- 714/734 714/735 714/738 2 2 2

PLUS Search Results for S/N 10026560, Searched August 10, 2004

The Patent Linguistics Utility System (PLUS) is a USPTO automated sear ch

system for U.S. Patents from 1971 to the present. PLUS is a query-by-example search system which produces a list of patents that a re

most closely related linguistically to the application searched. This search was prepared by the staff of the Scientific and Technical Information Center, SIRA.

RE31582

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4504929
RE31864
4510580
4519077
4574068
4580230
4601032
4622652
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